### 2025년 2월 12일(수)-14일(금) | 강원도 하이원리조트

### Future Normal in Semiconductor

2025년 2월 13일(목), 09:00-10:45 Room H(루비 I), 5층

# F. Silicon and Group-IV Devices and Integration Technology 분과 008\_[TH1-F] Memory Device Technology

좌장: 이용규 마스터(삼성전자), 김경록 교수(울산과학기술원)

46. Well billion, 604 ET(2047/20)	
초청 TH1-F-1 09:00-09:30	Evolution of Flash Memory Device Technology in Al Era Suk-Kang Sung Samsung Electronics Co., Ltd.
TH1-F-2 09:30-09:45	Self-Defect Compensated IGZO/ITO Capacitors for Memory Applications Sumin Han and Changhwan Shin School of Electrical Engineering, Korea University
TH1-F-3 09:45-10:00	V <sub>t</sub> Tuning Without Memory Window Reduction in HZO-based FeFET Using Fluorine Surface Treatment for High-Performance Analog In-Memory Computing Kyungsoo Park, Chulwon Chung, Seung Hyun Yoon, Junhyeok Park, and Changhwan Choi Division of Materials Science and Engineering, Hanyang University
TH1-F-4 10:00-10:15	A Study on the Neuromorphic Synaptic Characteristics of Mesh-Type Floating Gate Transistors  So Yeon Jeong <sup>1</sup> , Jae Min Kim <sup>1</sup> , Hyeong Jin Chae <sup>1</sup> , Tae Hwan Koo <sup>1</sup> , Ju Yeong Chae <sup>1</sup> , Hyeon Seok Jeong <sup>1</sup> , and Moon Gyu Jang <sup>1,2</sup> <sup>1</sup> School of Nano Convergence Technology, Hallym University, <sup>2</sup> Nano Convergence Technology Center, Hallym University
TH1-F-5 10:15-10:30	Design of Current Sense Amplifier for SRAM Consisting of a Feedback Field-Effect Transistor Jong Hyeok Oh and Yun Seop Yu Major of ICT & Robotics Eng., Hankyong National University

## 2025년 2월 12일(수)-14일(금) | 강원도 하이원리조트

# Future Normal in Semiconductor

H1-F-6 10:30-10:45	Top-Gate Oxide Semiconductor FETs for Reliable 2T0C Read/Write
	Operation with Reduced Capacitive Coupling
	Minho Park <sup>1</sup> , Hyeonho Gu <sup>1</sup> , Hyeonjin Lee <sup>2</sup> , Yongwoo Lee <sup>1</sup> , and Jimin Kwon <sup>1,2</sup>
	<sup>1</sup> Department of Electrical Engineering, UNIST, <sup>2</sup> Graduate School of Semiconductor
	Materials and Devices Engineering, UNIST